



Sheet 1 of 1

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO.

826.1785

APPLICATION NO.

10/052,511

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

FIRST NAMED INVENTOR

Megumi NAGATA, et al.

FILING DATE

January 23, 2002

GROUP ART UNIT

2818 2/25

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
Amr	AG	2000-101097	4/7/00	Japan			X	
	AH							
	AI							
	AJ							
	AK							
	AL							

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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

QwP	AM	W. T. Weeks, et al., Resistive and Inductive Skin Effect in Rectangular Conductors, November 1979, pp. 652-660, vol. 23, no. 6. IBM J. RESEARCH & DEVELOP
	AN	Analysis Tools For High-Speed Digital Signal Circuits, before June 2000, pp. 27, 28, and 30

SOURCE
NOT
IDENTIFIED
AND
NO
DOCUMENT
PROVIDED

EXAMINER

ALBERT W. PALADIN
PATENT EXAMINER

DATE CONSIDERED

8-19-05

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



ATTACHMENT 1(g)

LIST OF ADDITIONAL SUBMITTED DOCUMENTS

ATTORNEY DOCKET NO.	APPLICATION NO.
826.1785	10/052,511
FIRST NAMED INVENTOR	
Megumi NAGATA, et al.	
FILING DATE	GROUP ART UNIT
January 23, 2002	2818 2125

The following document(s) is/are listed in accordance with the duty of disclosure provisions of 37 CFR § 1.56, so that the Examiner may consider same should he deem any thereof to be material to examination of the subject application. Pursuant to 37 CFR 1.98(a)(2)(iii), a copy of any identified copending application(s) is provided.

It is requested that the Examiner acknowledge his consideration of document(s) below-listed by initialing same in the space provided adjacent each such application and that the Examiner sign and date this form at the bottom thereof to confirm such consideration having been given.

This submission in no way represents an admission that any of the information listed herein constitutes prior art with respect to the subject application and unless and until such prior art status is established, this submission is not a request that the information presented herein be printed on the face of any patent issuing from the subject application in which this information is being filed.

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
	AA						
	AB						
	AC						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
							YES	NO
	AD							

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AE	Analysis Tools For High-Speed Digital Signal Circuits, before June 2000, pp. 27, 28, and 30
	AF	

EXAMINER ALBERT W. PALADIN PATENT EXAMINER <i>Albert W. Paladin</i>	DATE CONSIDERED 8-19-05
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